Application/Control No. Applicant(s)/Patent Under Reexamination 10/642,299 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Krishnan S. Menon 1723 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0053422 03-2004 Chan et al. 436/180 Α US-6,814,859 11-2004 Koehler et al. В 210/198.2 US-С US-D US-Ε F US-US-G US-Н US-US-US-K US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Country Name Classification MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W